



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2813

Examiner: Jack S. J. CHEN

In Re PATENT APPLICATION Of:

Applicants: Toshikazu MIZUKOSHI

Serial No.: 10/635,506

Filed: August 7, 2003

For: METHOD OF FABRICATING A

SEMICONDUCTOR DEVICE HAVING

**TRENCHES** 

Docket No.: OKI 361

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(c), i.e., after a first Office Action on the merits but before Final Rejection and/or Notice of Allowance.

Attached is a copy of a Japanese patent publication. Also listed for consideration is one U.S. patent publication, which is the U.S. counterpart of the cited Japanese patent publication, and from which any relevance of the Japanese patent publication may be gleaned. The Japanese patent publication was first cited in a Japanese Office Action that was issued by the Japanese Patent Office in connection with a Japanese counterpart application. The publications are listed on the attached Form PTO-1449.

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INFORMATION
DISCLOSURE
STATEMENT WITH
CERTIFICATION

It is hereby certified that each item of information contained in the Information Disclosure Statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Information Disclosure Statement.

Consideration of the listed documents is respectfully requested.

Respectfully submitted,

<u>July 13, 2004</u> Date

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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT				Atty. Docket OKI 361		Application No. 10/635,506		
				Applicant Toshikazu MIZUKOSHI				
				Filing Date August 7, 2003	Group 2813	Group 2813		
			U.S	S. PATENT DOCUMENTS		· 		
Examiner Initial		Document Number	Date	Name	Class	Sub- Class	Filing Date	
	AA	US 6,242,323	06/05/01	Ishitsuka et al.				
	AB					1		
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Examiner

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.